

<b>Notice of References Cited</b>	Application/Control No. 10/064,672		Applicant(s)/Patent Under Reexamination LAI ET AL.	
	Examiner Brian L. De Grano		Art Unit 2632	Page 1 of 1

**U.S. PATENT DOCUMENTS**

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*	B	US-2002/0173344	11-2002	Cupps et al.	455/566
*	C	US-5,792,971	08-1998	Timis et al.	84/609
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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